

Search Notes

Application/Control No.

10/607,252

Examiner

Mark Eashoo, Ph.D.

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR,EPO,JPO, DERWENT)- see search history printout	11/13/2005	ME
Inventor Name Search (see search history printout)	11/13/2005	ME